Application/Control No. Applicant(s)/Patent Under Reexamination 10/681,647 KIM ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Hiep Nguyen 2816 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-4,384,277 05-1983 Allgood et al. 341/150 Α US-6,835,884 12-2004 84/609 Iwamoto et al. В US-С US-D US-E US-F US-G US-Н USı US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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